

Addition/Correction

Structural Influence on Raman Scattering of a New C Thin Film Prepared by AAO Template with the Method of Pressure Difference

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J. Comb. Chem., **2008**, 10 (4), 611-612 • DOI: 10.1021/cc800088q • Publication Date (Web): 05 June 2008

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Additions and Corrections

Zhixun Luo and Yan Fang*: Structural Influence on Raman Scattering of a New C₆₀ Thin Film Prepared by AAO Template with the Method of Pressure Difference

(*J. Comb. Chem.* 2006, 8, 500–504)

The captions for Figures 3–8 are incorrect as originally published. The corrected versions are below with the corresponding figure.

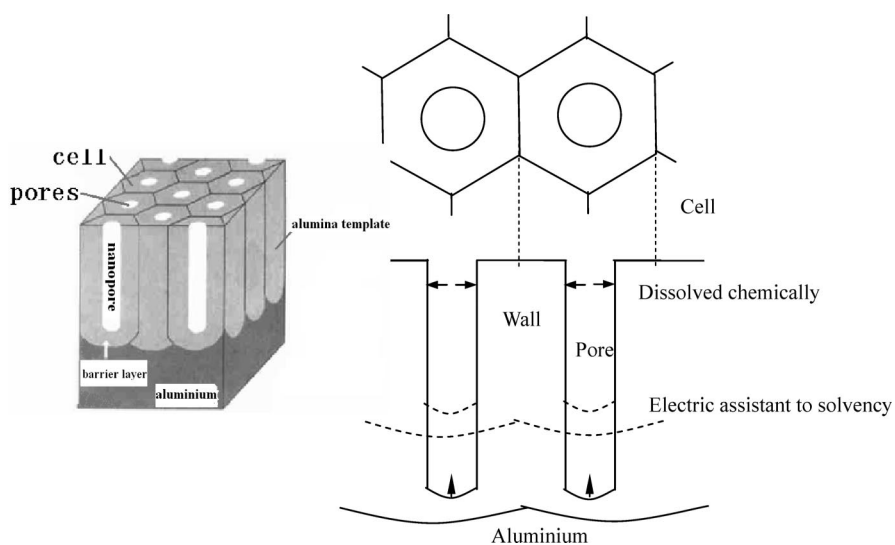


Figure 3. Sketch map of the growth of the regular pores in AAO template.

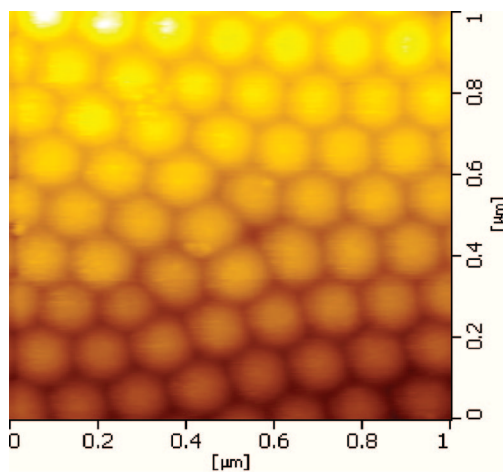


Figure 4. AFM image of C₆₀ thin film on AAO template.

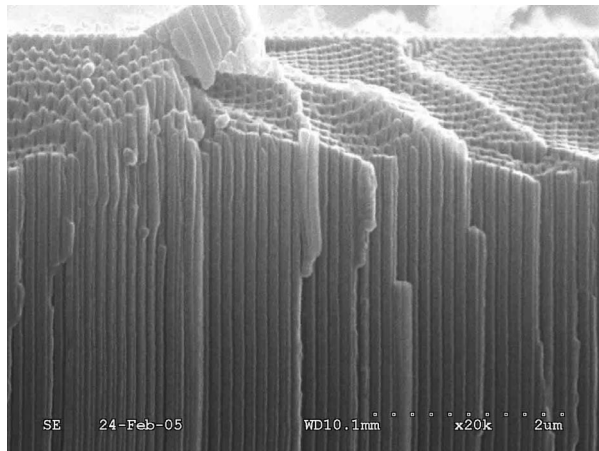


Figure 5. SEM photo of AAO template filled with C₆₀ rods or tubes from the cross side.

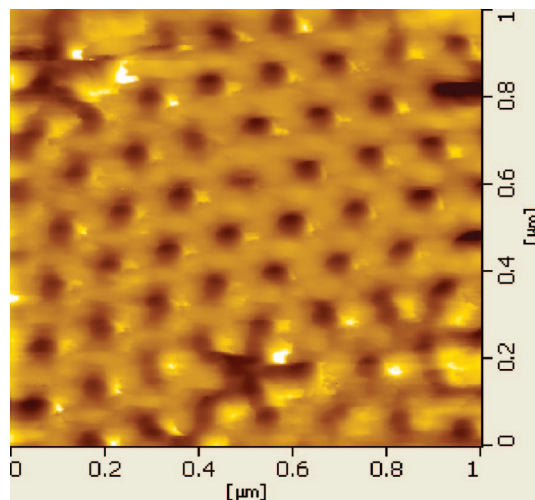


Figure 6. AFM image of AAO template filled or half filled with C₆₀ rods or tubes in its pores (from the other side).

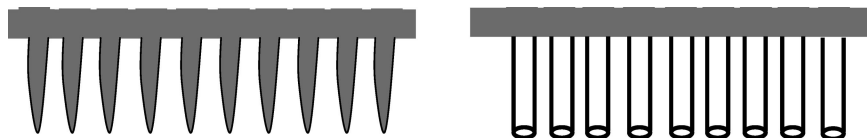


Figure 7. Sketch map of the brushlike thin film of C₆₀ with rods or tubes.

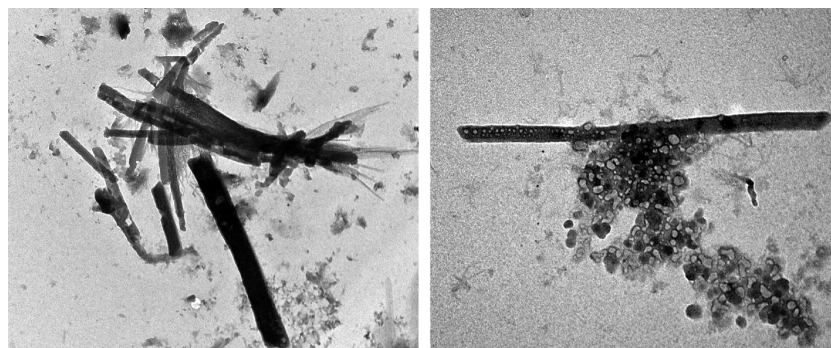


Figure 8. TEM photos of the C₆₀ rods or clusters prepared by AAO.